

<b>Notice of References Cited</b>	Application/Control No. 10/081,839	Applicant(s)/Patent Under Reexamination TAKAHASHI, HIROHARU	
	Examiner Philip B Tran	Art Unit 2155	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,490,052	12-2002	Yanagidaira, Kazumi	709/203
	B	US-6,240,456	05-2001	Teng et al.	709/225
	C	US-6,603,565	08-2003	Scheidig et al.	358/1.13
	D	US-6,369,909	04-2002	Shima, Toshihiro	358/1.15
	E	US-6,532,491	03-2003	Lakis et al.	709/223
	F	US-6,119,156	09-2000	Filion et al.	709/223
	G	US-6,631,407	10-2003	Mukaiyama et al.	709/223
	H	US-6,477,567	11-2002	Ohara, Kiyotaka	709/223
	I	US-6,615,372	09-2003	Wang, James	714/46
	J	US-6,003,078	12-1999	Kodimer et al.	709/224
	K	US-6,021,429	02-2000	Danknick, Dan	709/250
	L	US-2002/0078183	06-2002	Helms, Janine L.	709/220
	M	US-2002/0078160	06-2002	Kemp et al.	709/203

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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	X	

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